

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc., has assessed the Laboratory of:

***Centro de Máquinas de Medición, S.A. de C.V.
Ave. López Mateos # 1099 - A - 7 Col. Margarita Salazar
San Nicolas de los Garza, Nuevo León, México 66479***

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025: 2005

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated January 2009):

***Dimensional Inspection
(As detailed in the supplement)***

Such testing and/or calibration services shall only be offered at or from the address given above. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

The validity of this certificate is mandated through ongoing surveillance.

Tracy Szerszen
President/Operations Manager
Perry Johnson Laboratory
Accreditation, Inc. (PJLA)
26555 Evergreen, Suite 1325
Southfield, Michigan 48076

Initial Accreditation Date:
June 12, 2009

Accreditation No.
61872

Issue Date:
June 12, 2009

Certificate No.
L09-61

Expiration Date:
November 25, 2013

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Certificate of Accreditation: Supplement

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Accreditation is granted to this facility to perform the following testing:

FIELD OF TEST	ITEMS, MATERIALS OR PRODUCTS TESTED	SPECIFIC TESTS OR PROPERTIES MEASURED	SPECIFICATION, STANDARD METHOD OR TECHNIQUE USED	RANGE (WHERE APPROPRIATE) AND DETECTION LIMIT
Dimensional Inspection	Finished or Unfinished Parts From Machining Tools, Plastic Injections, Die Casting, and Electronics	Size, Location, and Form Tolerances	ASME Y14.5M-2005	Up to 1 500 mm Detection Limit 1.2 μm